

Notice of References Cited	Application/Control No. 10/531,908	Applicant(s)/Patent Under Reexamination BOPPEL ET AL.	
	Examiner Evan H. Langdon	Art Unit 3654	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,025,303 B2	04-2006	Meyer, Helmut	242/615.12
*	B	US-6,796,524 B2	09-2004	Pollock et al.	242/615.12
*	C	US-6,722,608 B1	04-2004	Gavit et al.	242/615.12
*	D	US-6,364,247 B1	04-2002	Polkinghorne, David T.	242/615.11
*	E	US-4,416,201 A	11-1983	Kessler, John R.	101/348
*	F	US-5,316,199 A	05-1994	Hansen et al.	242/615.12
*	G	US-2006/0278360 A1	12-2006	Solberg, Bruce Jerome	162/272
*	H	US-7,100,864 B2	09-2006	Weis, Anton	242/615.12
*	I	US-5,464,143 A	11-1995	Hansen, Robert E.	242/615.12
*	J	US-2005/0017123 A1	01-2005	Meyer, Helmut	242/615.12
*	K	US-6,004,432 A	12-1999	Page et al.	162/281
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 07053102	02-1995	Japan	Takenaka	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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